


<b>Search Notes</b> 	<b>Application/Control No.</b> 10594415	<b>Applicant(s)/Patent Under Reexamination</b> VIERA, PEDRO QUEIROZ
	<b>Examiner</b> SANG Y PAIK	<b>Art Unit</b> 3742

SEARCHED			
Class	Subclass	Date	Examiner
392	386-406	9/16/09	sp
239	34-60	9/16/09	sp
219	385, 391-401	9/16/09	sp

SEARCH NOTES		
Search Notes	Date	Examiner
east searched	9/16/09	sp

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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